


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517219	<b>Applicant(s)/Patent Under Reexamination</b>  CHRISTEN, YVES
	<b>Examiner</b>  Chen, Catheryne	<b>Art Unit</b>  1655

SEARCHED			
Class	Subclass	Date	Examiner
none	none	3/14/07	cc

SEARCH NOTES		
Search Notes	Date	Examiner
invetor name, USPT, PGPB, JPAB, EPAB, DWPI, Medline, Embase, Bisosis, Caplus, Registryn	3/14/07	cc
updated search	10/05/07	CC
updated search	12/4/08	CC
updated search	6/17/09	CC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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